



Form PTO-1449				ATTY. DOCKET NO. 0951-0128P		APPLICATION NO. 10/726,566			
<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> (Use several sheets if necessary)				APPLICANT YASHIRO, et al.					
				FILING DATE December 4, 2003		GROUP 2829			
<b>U.S. PATENT DOCUMENTS</b>									
EXAMINER INITIAL	DOCUMENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
	US								
	US								
	US								
	US								
	US								
	US								
	US								
	US								
	US								
	US								
<b>FOREIGN PATENT DOCUMENTS</b>									
	Office	DOCUMENT NUMBER	Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
								YES	NO
JN	JP	8-189931	A	1996-07-23	JAPAN	—	—	X*	
<b>OTHER DOCUMENTS</b> (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)									
EXAMINER	Jimmy Nguyen				DATE CONSIDERED				
				8/16/04					
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									

Form PTO-1449						ATTY. DOCKET NO. NEW		APPLICATION NO. NEW	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (Use several sheets if necessary)						APPLICANT YASHIRO, Yuji et al			
						FILING DATE December 4, 2003		GROUP 2829	
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL	DOCUMENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
JN	US 6,198,300	B1	2001-03-06	Doezema et al.	-	-			
JN	US 6,139,759	A	2000-10-31	Doezema et al.	-	-			
	US								
	US								
	US								
	US								
	US								
	US								
	US								
	US								
FOREIGN PATENT DOCUMENTS									
	Office	DOCUMENT NUMBER	Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES NO	
OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.									
JN	Yabuhara et al., "Scanning capacitance microscopy measurements using diamond-coated probes" American Vacuum Society 2002 pages 783-786								
EXAMINER Jimmy Nguyen					DATE CONSIDERED 8/16/04				
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									